

Notice of References Cited	Application/Control No. 10/605,202	Applicant(s)/Patent Under Reexamination BAXTER, JOHN F.	
	Examiner Zhiyu Lu	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0183059	12-2002	Noreen et al.	455/427
*	B	US-2003/0036967	02-2003	Deguchi, Yuichiro	705/26
*	C	US-2003/0050058	03-2003	Walsh et al.	455/426
*	D	US-6,505,160	01-2003	Levy et al.	704/270
*	E	US-4,528,696	07-1985	Martin, III, Robert J.	455/73
*	F	US-2002/0155815	10-2002	Richter, Thomas	455/67.1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.